CDCLVP1208 Eight LVPECL Output, High-Performance Clock 2:8 Buffer

1 Features

- 2:8 Differential Buffer
- Selectable Clock Inputs Through Control terminal
- Universal Inputs Accept LVPECL, LVDS, and LVCMOS/LVTTL
- Eight LVPECL Outputs
- Maximum Clock Frequency: 2 GHz
- Maximum Core Current Consumption: 73 mA
- Very Low Additive Jitter: <100 fs,rms in 10 kHz to 20 MHz Offset Range:
  - 57 fs, rms (typical) at 122.88 MHz
  - 48 fs, rms (typical) at 156.25 MHz
  - 30 fs, rms (typical) at 312.5 MHz
- 2.375-V to 3.6-V Device Power Supply
- Maximum Propagation Delay: 450 ps
- Maximum Output Skew: 20 ps
- LVPECL Reference Voltage, V_{AC_REF}, Available for Capacitive-Coupled Inputs
- Industrial Temperature Range: –40°C to 85°C
- Supports 105°C PCB Temperature (Measured with a Thermal Pad)
- ESD Protection Exceeds 2 kV (HBM)
- Available in 5-mm × 5-mm QFN-28 (RHD) Package

2 Applications

- Wireless Communications
- Telecommunications/Networking
- Medical Imaging
- Test and Measurement Equipment

3 Description

The CDCLVP1208 is a highly versatile, low additive jitter buffer that can generate eight copies of LVPECL clock outputs from one of two selectable LVPECL, LVDS, or LVCMOS inputs for a variety of communication applications. It has a maximum clock frequency up to 2 GHz. The CDCLVP1208 features an on-chip multiplexer (MUX) for selecting one of two inputs that can be easily configured solely through a control terminal. The overall additive jitter performance is less than 0.1 ps, RMS from 10 kHz to 20 MHz, and overall output skew is as low as 20 ps, making the device a perfect choice for use in demanding applications.

The CDCLVP1208 clock buffer distributes one of two selectable clock inputs (IN0, IN1) to eight pairs of differential LVPECL clock outputs (OUT0, OUT7) with minimum skew for clock distribution. The CDCLVP1208 can accept two clock sources into an input multiplexer. The inputs can be LVPECL, LVDS, or LVCMOS/LVTTL.

The CDCLVP1208 is specifically designed for driving 50-Ω transmission lines. When driving the inputs in single-ended mode, the LVPECL bias voltage (V_{AC_REF}) should be applied to the unused negative input terminal. However, for high-speed performance up to 2 GHz, differential mode is strongly recommended.

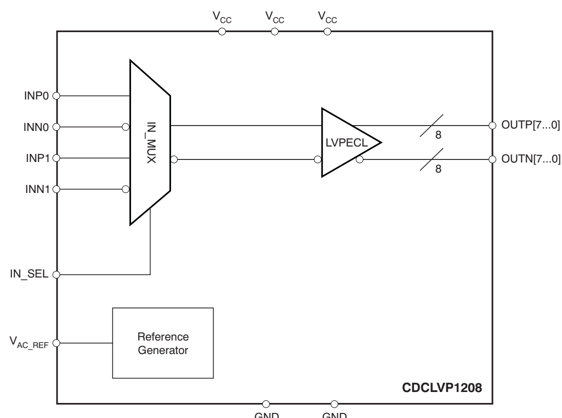
The CDCLVP1208 is packaged in a small 28-pin, 5-mm x 5-mm QFN package and is characterized for operation from –40°C to 85°C.

Device Information(1)

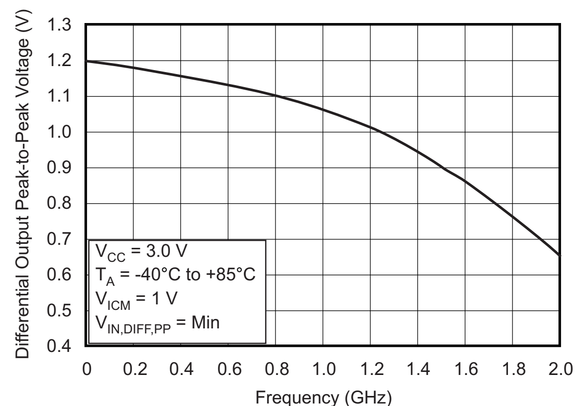
PART NUMBER	PACKAGE	BODY SIZE (NOM)
CDCLVP1208	QFN (28)	5.00 mm x 5.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Functional Block Diagram



Differential Output Peak-to-Peak Voltage vs Frequency



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (September 2014) to Revision E — **Page**

- Added Support for 105ºC thermal pad temperature ... 1
- Deleted *Device Comparison* table; information in POA ... 1
- Changed order of pin descriptions to alphabetical ... 4
- Changed *Handing Ratings* to *ESD Ratings;* moved T_J and storage temperature to *Absolute Maximum Ratings* ... 5
- Added PCB temperature in *Recommended Operating Conditions* ... 5
- Added V_{OH} specification for T_{PCB}≤ 105ºC in Electrical Characteristics: LVPECL Output, at VCC = 2.375 V to 2.625 V ... 6
- Added V_{OL} specification for T_{PCB}≤ 105ºC in Electrical Characteristics: LVPECL Output, at VCC = 2.375 V to 2.625 V ... 6
- Added I_{EE} specification for T_{PCB} ≤ 105ºC in Electrical Characteristics: LVPECL Output, at VCC = 2.375 V to 2.625 V ... 7
- Added I_{CC} specification for T_{PCB} ≤ 105ºC in Electrical Characteristics: LVPECL Output, at VCC = 2.375 V to 2.625 V ... 7
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- Added I_{EE} specification for T_{PCB} ≤ 105ºC in Electrical Characteristics: LVPECL Output, at VCC = 3 V to 3.6 V ... 8
- Added I_{CC} specification for T_{PCB} ≤ 105ºC in Electrical Characteristics: LVPECL Output, at VCC = 3 V to 3.6 V ... 9
- Added *Thermal Considerations* section ... 21

Changes from Revision C (June 2014) to Revision D — **Page**

- Added "NOTE" at the beginning of "Applications and Implementation" section ... 18
- Changed JEDEC symbol to $R_{θJA}$ ... 20

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Changes from Revision B (August 2011) to Revision C — **Page**

- Added data sheet flow and layout to conform with new TI standards. Added the following sections: Application and Implementation; Power Supply Recommendations; Layout; Device and Documentation Support; Mechanical, Packaging, and Ordering Information. 1
- Added f_{IN} = 125 MHz, 312.5 MHz for $V_{OUT,\ DIFF,\ PP}$ 6
- Added Typical values, Max values, and footnotes for 122.88 MHz, 156.25 MHz, and 312.5 MHz test conditions corresponding to Random Additive Jitter for Electrical Characteristics: LVPECL Output, at V_{CC} = 2.375 V to 2.625 V 7
- Added Typical values, Max values, and footnotes for 122.88 MHz, 156.25 MHz, and 312.5 MHz test conditions corresponding to Random Additive Jitter for Electrical Characteristics: LVPECL Output, at V_{CC} = 3.0 V to 3.6 V 8

Changes from Revision A (May 2010) to Revision B — **Page**

- Revised description of pin 7 4
- Corrected V_{IL} parameter description in *Electrical Characteristics* table for LVCMOS input 6
- Added [1]footnote (2) to *Electrical Characteristics* table for LVPECL Output, VCC = 2.375 V to 2.625 V 6
- Changed recommended resistor values in Figure 12(a) 14
- Changed recommended resistor values in Figure 16 16

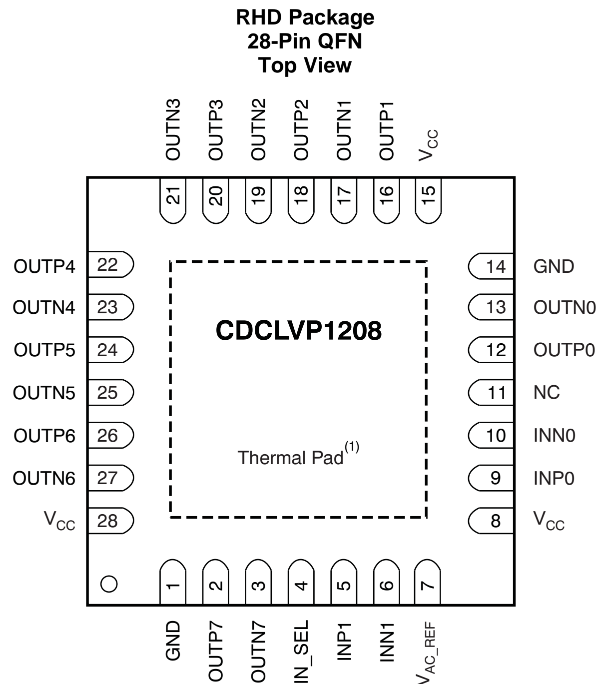
(1) Internally generated bias voltage (V_{AC_REF}) is for 3.3 V operation only. It is recommended to apply externally generated bias voltage for V_{CC} < 3.0 V.

Changes from Original (October, 2009) to Revision A — **Page**

- Changed description of INN1, INN0 and INP1, INP0 pins in *Pin Descriptions* table 4
- Changed descriptions of all output pins in *Pin Descriptions* table 4

5 Pin Configuration and Functions

RHD Package
28-Pin QFN
Top View



(1) Thermal pad must be soldered to ground.

Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NUMBER		
GND	1, 14	Ground	Device grounds
INP0, INN0	9, 10	Input	Differential input pair or single-ended input. Unused input pair can be left floating.
INP1, INN1	5, 6	Input	Redundant differential input pair or single-ended input. Unused input pair can be left floating.
IN_SEL	4	Input	Pulldown (see *Pin Characteristics*) MUX select input for input choice (see Table 1)
OUTP7, OUTN7	2, 3	Output	Differential LVPECL output pair no. 7. Unused output pair can be left floating.
OUTP6, OUTN6	26, 27	Output	Differential LVPECL output pair no. 6. Unused output pair can be left floating.
OUTP5, OUTN5	24, 25	Output	Differential LVPECL output pair no. 5. Unused output pair can be left floating.
OUTP4, OUTN4	22, 23	Output	Differential LVPECL output pair no. 4. Unused output pair can be left floating.
OUTP3, OUTN3	20, 21	Output	Differential LVPECL output pair no. 3. Unused output pair can be left floating.
OUTP2, OUTN2	18, 19	Output	Differential LVPECL output pair no. 2. Unused output pair can be left floating.
OUTP1, OUTN1	16, 17	Output	Differential LVPECL output pair no. 1. Unused output pair can be left floating.
OUTP0 OUTN0	12, 13	Output	Differential LVPECL output pair no. 0. Unused output pair can be left floating.
V_{AC_REF}	7	Output	bias voltage output for capacitive coupled inputs. Do not use V_{AC_REF} at V_{CC} < 3 V. If used, it is recommended to use a 0.1-µF capacitor to GND on this pin. The output current is limited to 2 mA.
V_{CC}	8, 15, 28	Power	2.5-/3.3-V supplies for the device
NC	11	—	Do not connect

Table 1. Input Selection Table

IN_SEL	ACTIVE CLOCK INPUT
0	INP0, INN0
1	INP1, INN1

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) [(1)]

		MIN	MAX	UNIT
V_{CC}	Supply voltage [(2)]	–0.5	4.6	V
V_{IN}	Input voltage [(3)]	–0.5	V_{CC} + 0.5	V
V_{OUT}	Output voltage [(3)]	–0.5	V_{CC} + 0.5	V
I_{IN}	Input current		20	mA
I_{OUT}	Output current		50	mA
T_A	Specified free-air temperature range (no airflow)	–40	85	°C
T_J	Maximum junction temperature		125	°C
T_{stg}	Storage temperature range	–65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) All supply voltages must be supplied simultaneously.
(3) The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 [(1)]	±2000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	2.375	2.50/3.3	3.60	V
T_A	Ambient temperature	–40		85	°C
T_{PCB}	PCB temperature (measured at thermal pad)			105	°C

6.4 Thermal Information

THERMAL METRIC [(1)]		CDCLVP1208	UNIT
		RHD (QFN)	
		28 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	39.8, 0 LFM	°C/W
		33.1, 150 LFM	°C/W
		31.4, 400 LFM	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	30	°C/W
$R_{\theta JP}$ [(2)]	Thermal resistance, junction-to-pad	6.12	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	0.5	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	11.4	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	6.12	°C/W

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.
(2) $R_{\theta JP}$ (junction-to-pad) is used for the QFN package, because the primary heat flow is from the junction to the GND pad of the QFN package.

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6.5 Electrical Characteristics: LVCMOS Input

at V_{CC} = 2.375 V to 3.6 V and T_A = –40°C to 85°C and T_{PCB} ≤ 105°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{IN}	Input frequency				200	MHz
V_{th}	Input threshold voltage	External threshold voltage applied to complementary input	1.1		1.8	V
V_{IH}	Input high voltage		V_{th} + 0.1		V_{CC}	V
V_{IL}	Input low voltage		0		V_{th} – 0.1	V
I_{IH}	Input high current	V_{CC} = 3.6 V, V_{IH} = 3.6 V			40	µA
I_{IL}	Input low current	V_{CC} = 3.6 V, V_{IL} = 0 V			–40	µA
ΔV/ΔT	Input edge rate	20% to 80%	1.5			V/ns
I_{CAP}	Input capacitance			5		pF

(1) Figure 6 and Figure 7 show DC test setup.

6.6 Electrical Characteristics: Differential Input

at V_{CC} = 2.375 V to 3.6 V and T_A = –40°C to 85°C and T_{PCB} ≤ 105°C (unless otherwise noted)(1)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{IN}	Input frequency	Clock input			2000	MHz
$V_{IN, DIFF, PP}$	Differential input peak-peak voltage	f_{IN} ≤ 1.5 GHz	0.1		1.5	V
		1.5 GHz ≤ f_{IN} ≤ 2 GHz	0.2		1.5	V
V_{ICM}	Input common-mode level		1.0		V_{CC} – 0.3	V
I_{IH}	Input high current	V_{CC} = 3.6 V, V_{IH} = 3.6 V			40	µA
I_{IL}	Input low current	V_{CC} = 3.6 V, V_{IL} = 0 V			–40	µA
ΔV/ΔT	Input edge rate	20% to 80%	1.5			V/ns
I_{CAP}	Input capacitance			5		pF

(1) Figure 5 and Figure 8 show DC test setup. Figure 9 shows AC test setup.

6.7 Electrical Characteristics: LVPECL Output, at V_{CC} = 2.375 V to 2.625 V(1)

T_A = –40°C to 85°C and T_{PCB} ≤ 105°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	Output high voltage	T_A ≤ 85ºC	V_{CC} – 1.26		V_{CC} – 0.9	V
		T_{PCB} ≤ 105ºC	V_{CC} – 1.26		V_{CC} – 0.83	V
V_{OL}	Output low voltage	T_A ≤ 85ºC	V_{CC} – 1.7		V_{CC} – 1.3	V
		T_{PCB} ≤ 105ºC	V_{CC} – 1.7		V_{CC} – 1.25	V
$V_{OUT, DIFF, PP}$	Differential output peak-peak voltage	f_{IN} ≤ 2 GHz	0.5		1.35	V
		f_{IN} = 125 MHz, 312.5 MHz		1.15		
V_{AC_REF}	Input bias voltage	I_{AC_REF} = 2 mA	V_{CC} – 1.6		V_{CC} – 1.1	V
t_{PD}	Propagation delay	$V_{IN, DIFF, PP}$ = 0.1V			450	ps
		$V_{IN, DIFF, PP}$ = 0.3V			450	ps
$t_{SK,PP}$	Part-to-part skew				125	ps
$t_{SK,O}$	Output skew				20	ps
$t_{SK,P}$	Pulse skew (with 50% duty cycle input)	Crossing-point-to-crossing-point distortion, f_{OUT} = 100 MHz	–50		50	ps

(1) Figure 10 and Figure 11 show DC and AC test setup.

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Electrical Characteristics: LVPECL Output, at V_{CC} = 2.375 V to 2.625 V(1) (continued)

T_A = –40°C to 85°C and T_{PCB} ≤ 105°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{RJIT}	Random additive jitter (with 50% duty cycle input)(2)	f_{OUT} = 100 MHz, $V_{IN,SE}$ = V_{CC}, V_{th} = 1.25 V, 10 kHz to 20 MHz		0.081		ps, RMS
		f_{OUT} = 100 MHz, $V_{IN,SE}$ = 0.9 V, V_{th} = 1.1 V, 10 kHz to 20 MHz		0.091		ps, RMS
		f_{OUT} = 2 GHz, $V_{IN,DIFF,PP}$ = 0.2 V, V_{ICM} = 1 V, 10 kHz to 20 MHz		0.041		ps, RMS
		f_{OUT} = 100 MHz, $V_{IN,DIFF,PP}$ = 0.15 V, V_{ICM} = 1 V, 10 kHz to 20 MHz		0.088		ps, RMS
		f_{OUT} = 100 MHz, $V_{IN,DIFF,PP}$ = 1 V, V_{ICM} = 1 V, 10 kHz to 20 MHz		0.081		ps, RMS
		f_{OUT} = 122.88 MHz,(3)(4) Square Wave, V_{IN-PP} = 1 V, 12 kHz to 20 MHz		0.057	0.088	ps. RMS
		f_{OUT} = 122.88 MHz,(3)(4) Square Wave, V_{IN-PP} = 1 V, 10 kHz to 20 MHz		0.057	0.088	ps. RMS
		f_{OUT}= 122.88 MHz,(3)(4) Square Wave, V_{IN-PP} = 1 V, 1 kHz to 40 MHz		0.086	0.121	ps. RMS
		f_{OUT} = 156.25 MHz,(3)(5) Square Wave, V_{IN-PP} = 1 V, 12 kHz to 20 MHz		0.048	0.071	ps. RMS
		f_{OUT} = 156.25 MHz,(3)(5) Square Wave, V_{IN-PP} = 1 V, 10 kHz to 20 MHz		0.048	0.071	ps. RMS
		f_{OUT} = 156.25 MHz,(3)(5) Square Wave, V_{IN-PP} = 1 V, 1 kHz to 40 MHz		0.068	0.097	ps. RMS
		f_{OUT} = 312.5 MHz,(3)(6) Square Wave, V_{IN-PP} = 1 V, 12 kHz to 20 MHz		0.030	0.048	ps. RMS
		f_{OUT} = 312.5 MHz,(3)(6) Square Wave, V_{IN-PP} = 1 V, 10 kHz to 20 MHz		0.030	0.048	ps. RMS
		f_{OUT} = 312.5 MHz,(3)(6) Square Wave, V_{IN-PP} = 1 V, 1 kHz to 40 MHz		0.045	0.068	ps. RMS
t_R/t_F	Output rise/fall time	20% to 80%			200	ps
I_{EE}	Supply internal current	Outputs unterminated T_A ≤ 85ºC			73	mA
		Outputs unterminated, T_{PCB} ≤ 105ºC			73	mA
I_{CC}	Output and internal supply current	All outputs terminated, 50 Ω to V_{CC} – 2 T_A ≤ 85ºC			325	mA
		All outputs terminated, 50 Ω to V_{CC} – 2 T_{PCB} ≤ 105ºC			355	mA

(2) Parameter is specified by characterization. Not tested in production.
(3) Input source RMS Jitter (t_{RJIT_IN}) and Total RMS Jitter (t_{RJIT_OUT}) measured using Agilent E5052 Phase Noise Analyzer. Buffer device random additive jitter computed as: $t_{RJIT} = SQRT[(t_{RJIT_OUT})^2 - (t_{RJIT_IN})^2]$.
(4) Input source: 122.88-MHz Rohde & Schwarz SMA100A Signal Generator.
(5) Input source: 156.25-MHz Rohde & Schwarz SMA100A Signal Generator.
(6) Input source: 312.5-MHz Rohde & Schwarz SMA100A Signal Generator.

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6.8 Electrical Characteristics: LVPECL Output, at V_{CC} = 3 V to 3.6 V(1)

T_A = –40°C to 85°C and T_{PCB} ≤ 105°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	Output high voltage	T_A ≤ 85ºC	V_{CC} – 1.26		V_{CC} – 0.9	V
		T_{PCB} ≤ 105ºC	V_{CC} – 1.26		V_{CC} – 0.85	V
V_{OL}	Output low voltage	T_A ≤ 85ºC	V_{CC} – 1.7		V_{CC} – 1.3	V
		T_{PCB} ≤ 105ºC	V_{CC} – 1.7		V_{CC} – 1.3	V
$V_{OUT, DIFF, PP}$	Differential output peak-peak voltage	f_{IN} ≤ 2 GHz	0.65		1.35	V
V_{AC_REF}	Input bias voltage	I_{AC_REF} = 2 mA	V_{CC} – 1.6		V_{CC} – 1.1	V
t_{PD}	Propagation delay	$V_{IN, DIFF, PP}$ = 0.1V			450	ps
		$V_{IN, DIFF, PP}$ = 0.3V			450	ps
$t_{SK,PP}$	Part-to-part skew				125	ps
$t_{SK,O}$	Output skew				20	ps
$t_{SK,P}$	Pulse skew (with 50% duty cycle input)	Crossing-point-to-crossing-point distortion, f_{OUT} = 100 MHz	–50		50	ps
t_{RJIT}	Random additive jitter, (with 50% duty cycle input)(2)	f_{OUT} = 100 MHz, $V_{IN,SE}$ = V_{CC}, V_{th} = 1.65 V, 10 kHz to 20 MHz		0.101		ps, RMS
		f_{OUT} = 100 MHz, $V_{IN,SE}$ = 0.9 V, V_{th} = 1.1 V, 10 kHz to 20 MHz		0.13		ps, RMS
		f_{OUT} = 2 GHz, $V_{IN,DIFF,PP}$ = 0.2 V, V_{ICM} = 1 V, 10 kHz to 20 MHz		0.069		ps, RMS
		f_{OUT} = 100 MHz, $V_{IN,DIFF,PP}$ = 0.15 V, V_{ICM} = 1 V, 10 kHz to 20 MHz		0.094		ps, RMS
		f_{OUT} = 100 MHz, $V_{IN,DIFF,PP}$ = 1 V, V_{ICM} = 1 V, 10 kHz to 20 MHz		0.094		ps, RMS
		f_{OUT} = 122.88 MHz,(3)(4) Square Wave, V_{IN-PP} = 1 V, 12 kHz to 20 MHz		0.057		ps, RMS
		f_{OUT} = 122.88 MHz,(3)(4) Square Wave, V_{IN-PP} = 1 V, 10 kHz to 20 MHz		0.057		ps, RMS
		f_{OUT}= 122.88 MHz,(3)(4) Square Wave, V_{IN-PP} = 1 V, 1 kHz to 40 MHz		0.086		ps, RMS
		f_{OUT} = 156.25 MHz,(4)(5) Square Wave, V_{IN-PP} = 1 V, 12 kHz to 20 MHz		0.048		ps, RMS
		f_{OUT} = 156.25 MHz,(4)(5) Square Wave, V_{IN-PP} = 1 V, 10 kHz to 20 MHz		0.048		ps, RMS
		f_{OUT} = 156.25 MHz,(4)(5) Square Wave, V_{IN-PP} = 1 V, 1 kHz to 40 MHz		0.068		ps, RMS
		f_{OUT} = 312.5 MHz,(4)(6) Square Wave, V_{IN-PP} = 1 V, 12 kHz to 20 MHz		0.030		ps, RMS
		f_{OUT} = 312.5 MHz,(4)(6) Square Wave, V_{IN-PP} = 1 V, 10 kHz to 20 MHz		0.030		ps, RMS
		f_{OUT} = 312.5 MHz,(4)(6) Square Wave, V_{IN-PP} = 1 V, 1 kHz to 40 MHz		0.045		ps, RMS
t_R/t_F	Output rise/fall time	20% to 80%			200	ps
I_{EE}	Supply internal current	Outputs unterminated T_A ≤ 85ºC			73	mA
		Outputs unterminated, T_{PCB} ≤ 105ºC			73	mA

(1) Figure 10 and Figure 11 show DC and AC test setup.
(2) Parameter is specified by characterization. Not tested in production.
(3) Input source: 122.88-MHz Rohde & Schwarz SMA100A Signal Generator.
(4) Input source RMS Jitter (t_{RJIT_IN}) and Total RMS Jitter (t_{RJIT_OUT}) measured using Agilent E5052 Phase Noise Analyzer. Buffer device random additive jitter computed as: $t_{RJIT} = SQRT[(t_{RJIT_OUT})^2 - (t_{RJIT_IN})^2]$.
(5) Input source: 156.25-MHz Rohde & Schwarz SMA100A Signal Generator.
(6) Input source: 312.5-MHz Rohde & Schwarz SMA100A Signal Generator.

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Electrical Characteristics: LVPECL Output, at V_{CC} = 3 V to 3.6 V(1) (continued)

T_A = –40°C to 85°C and T_{PCB} ≤ 105°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{CC}	Output and internal supply current	All outputs terminated, 50 Ω to V_{CC} – 2 T_A ≤ 85ºC			325	mA
		All outputs terminated, 50 Ω to V_{CC} – 2 T_{PCB} ≤ 105ºC			355	mA

6.9 Pin Characteristics

PARAMETER		MIN	TYP	MAX	UNIT
$R_{PULLDOWN}$	Input pulldown resistor		150		kΩ

6.10 Timing Requirements

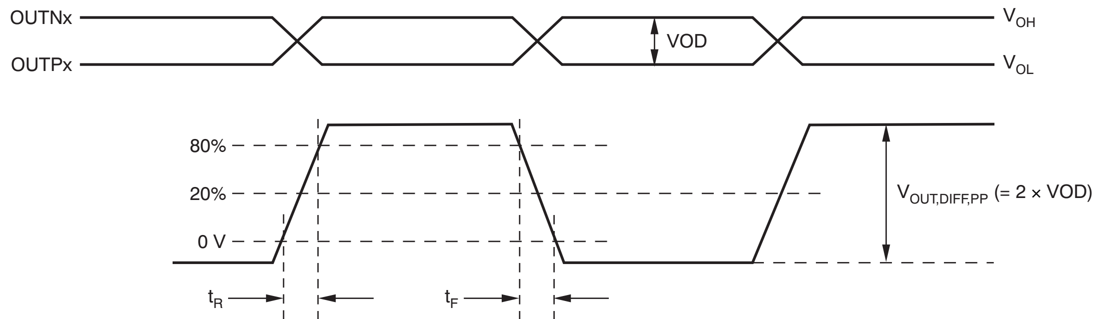
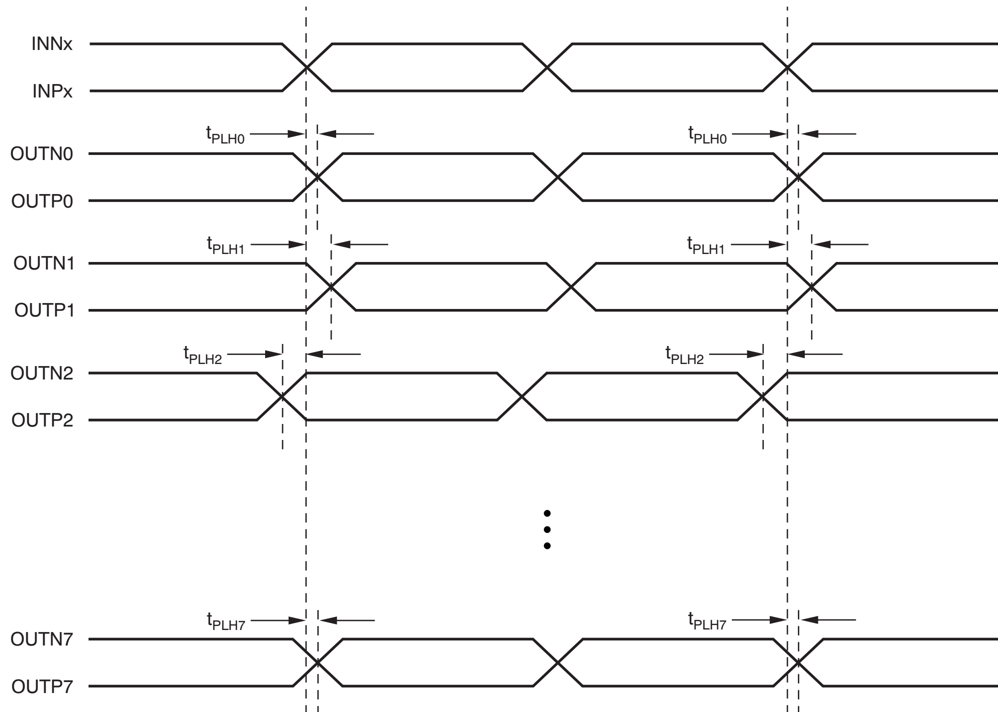


Figure 1. Output Voltage and Rise/Fall Time



(1) Output skew is calculated as the greater of the following: As the difference between the fastest and the slowest t_{PLHn} (n = 0, 1, 2....7), or as the difference between the fastest and the slowest t_{PHLn} (n = 0, 1, 2....7).

(2) Part-to-part skew is calculated as the greater of the following: As the difference between the fastest and the slowest t_{PLHn} (n = 0, 1, 2....7) across multiple devices, or the difference between the fastest and the slowest t_{PHLn} (n = 0, 1, 2....7) across multiple devices.

Figure 2. Output and Part-to-Part Skew

6.11 Typical Characteristics

at T_A = –40°C to +85°C (unless otherwise noted)

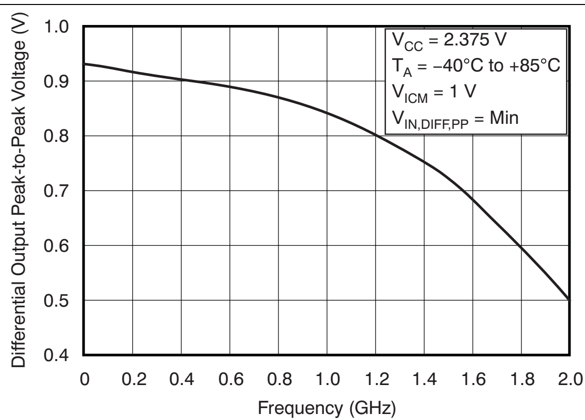


Figure 3. Differential Output Peak-to-Peak Voltage Vs Frequency

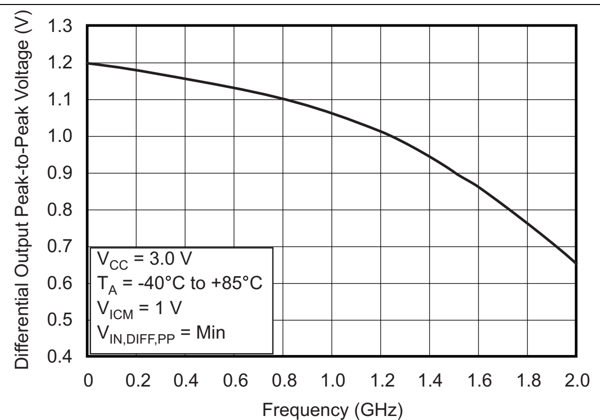


Figure 4. Differential Output Peak-to-Peak Voltage Vs Frequency

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7 Parameter Measurement Information

7.1 Test Configurations

Figure 5 through Figure 11 illustrate how the device should be set up for a variety of test configurations.

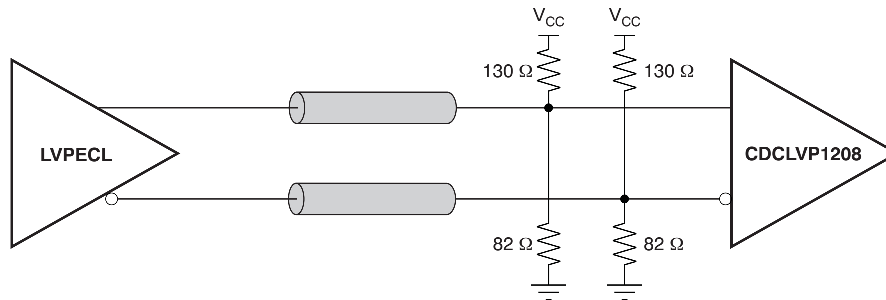

Figure 5. DC-Coupled LVPECL Input During Device Test

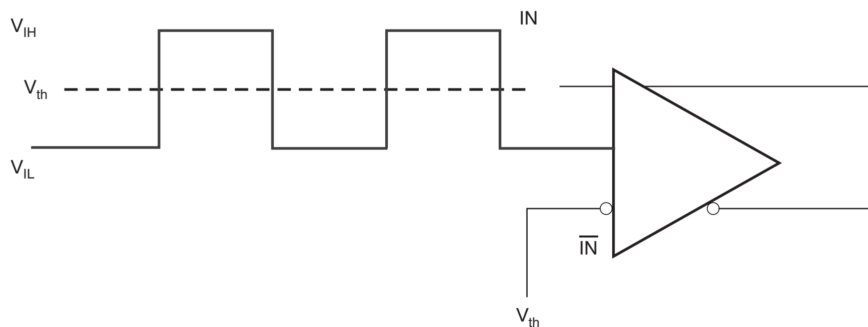

Figure 6. DC-Coupled LVCMOS Input During Device Test

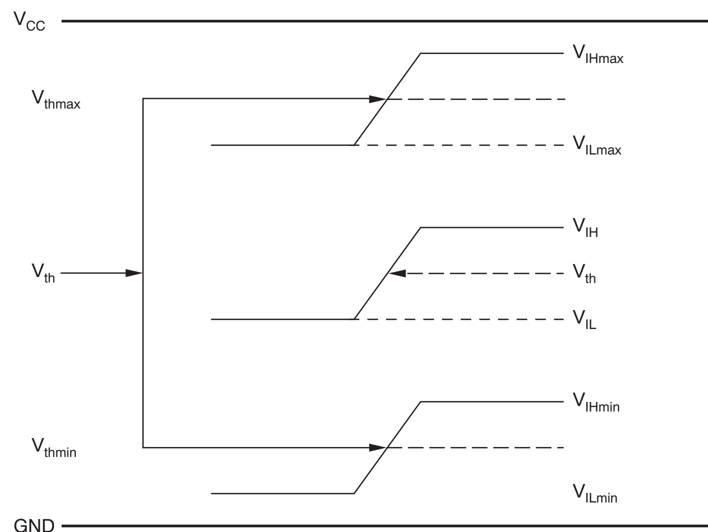

Figure 7. V_{th} Variation over LVCMOS V_{th} Levels

Test Configurations (continued)

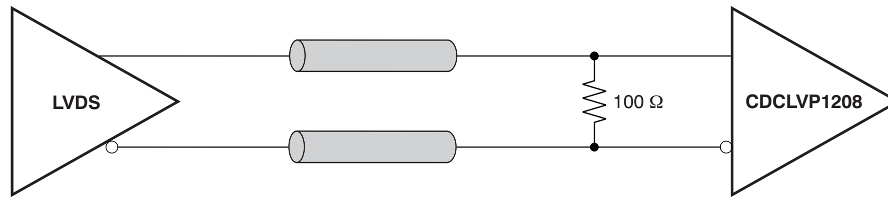

Figure 8. DC-Coupled LVDS Input During Device Test

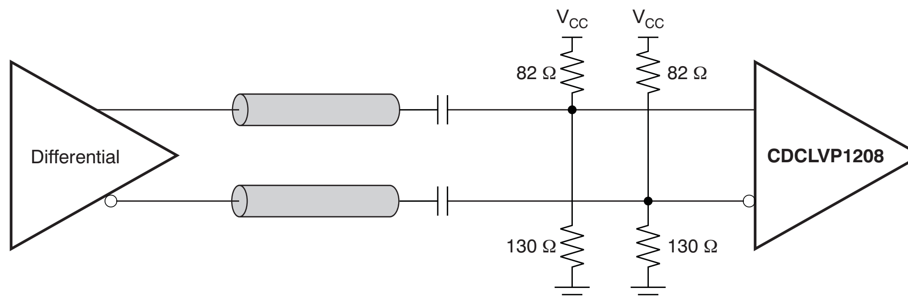

Figure 9. AC-Coupled Differential Input to Device

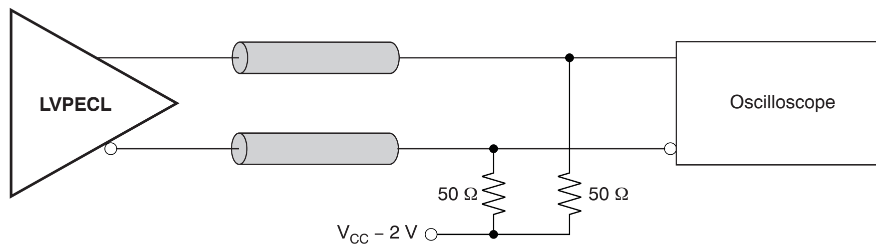

Figure 10. LVPECL Output DC Configuration During Device Test

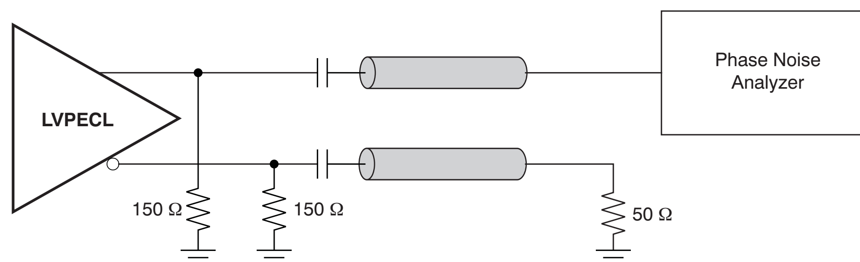

Figure 11. LVPECL Output AC Configuration During Device Test

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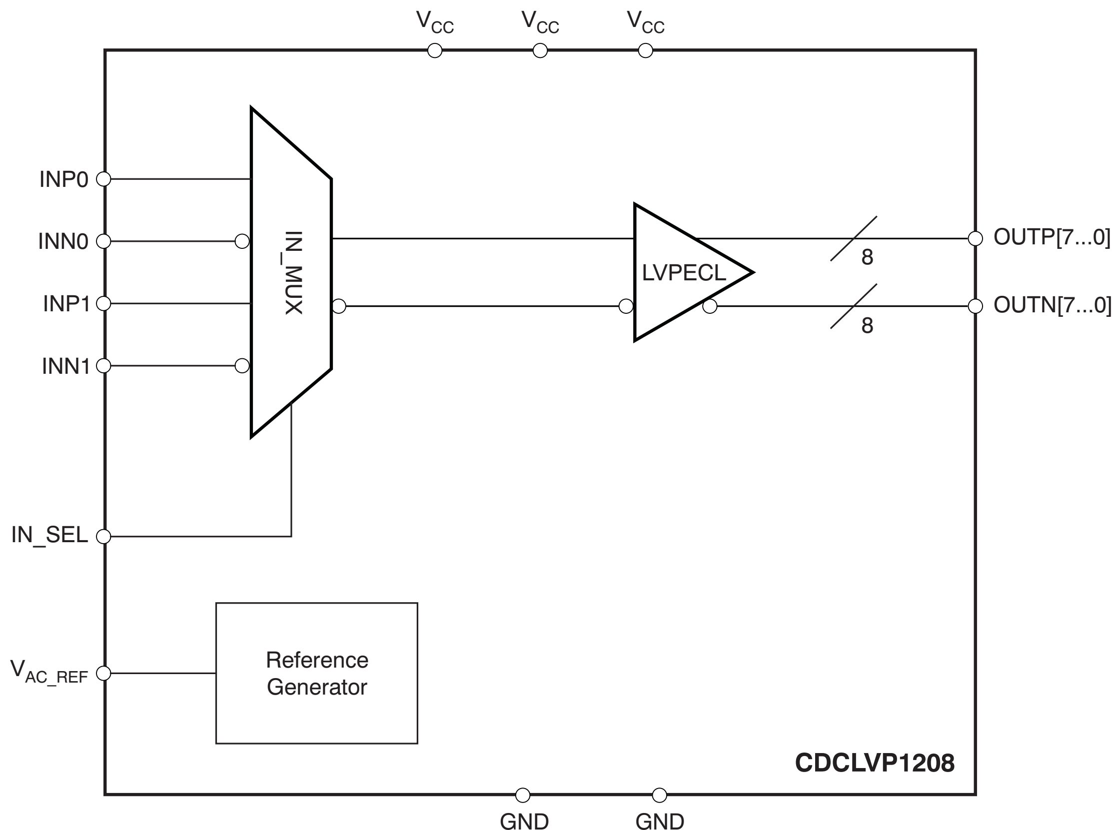
8 Detailed Description

8.1 Overview

The CDCLVP1208 is an open emitter for LVPECL outputs. Therefore, proper biasing and termination are required to ensure correct operation of the device and to minimize signal integrity. The proper termination for LVPECL outputs is a 50 Ω to (V_{CC} –2) V, but this DC voltage is not readily available on PCB. Therefore, a Thevenin equivalent circuit is worked out for the LVPECL termination in both direct-coupled (DC) and AC-coupled configurations. These configurations are shown in Figure 12 (a and b) for V_{CC} = 2.5 V and Figure 13 (a and b) for V_{CC} = 3.3 V, respectively. It is recommended to place all resistive components close to either the driver end or the receiver end. If the supply voltage for the driver and receiver is different, AC coupling is required.

8.2 Functional Block Diagram



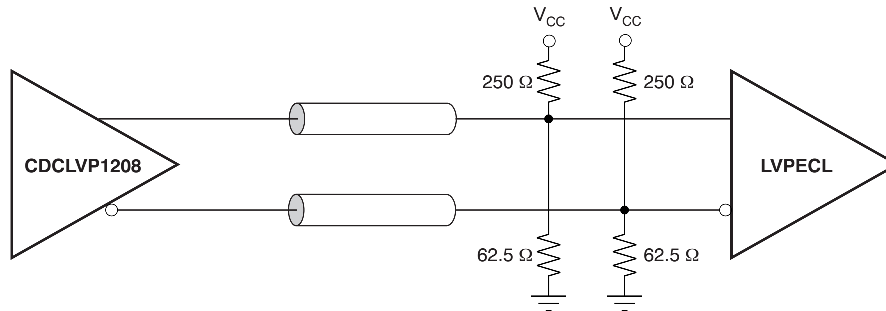
8.3 Feature Description

The CDCLVP1208 is a low additive jitter universal to LVPECL fan out buffer with 2 selectable inputs. The small package, low output skew, and low additive jitter make for a flexible device in demanding applications.

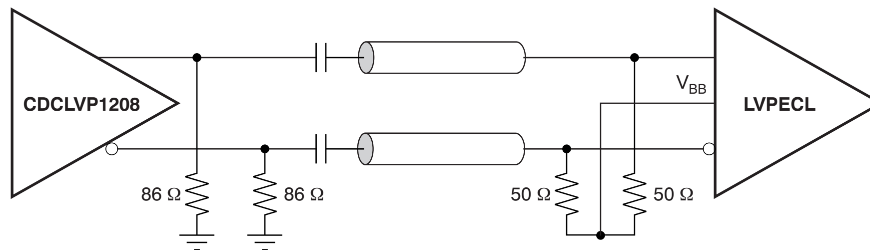
8.4 Device Functional Modes

The two inputs of the CDCLVP1208 are internally muxed together and can be selected via the control pin. Unused inputs and outputs can be left floating to reduce overall component cost. Both AC and DC coupling schemes can be used with the CDCLVP1208 to provide greater system flexibility.

8.4.1 LVPECL Output Termination



(a) Output DC Termination



(b) Output AC Termination

Figure 12. LVPECL Output DC and AC Termination for V_{CC} = 2.5 V

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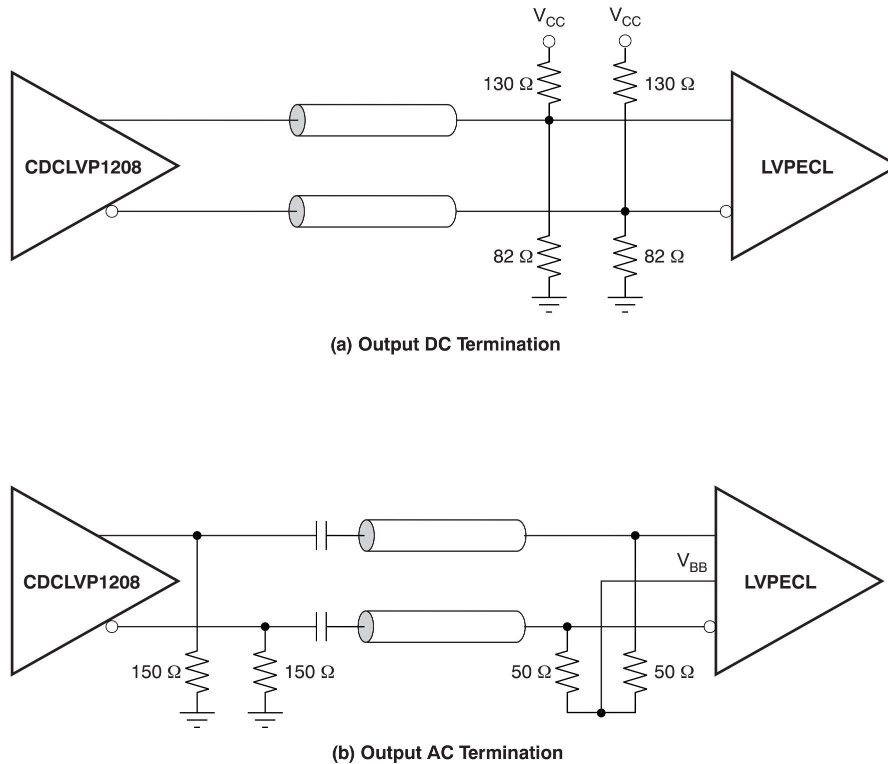
Device Functional Modes (continued)



(a) Output DC Termination

(b) Output AC Termination

Figure 13. LVPECL Output DC and AC Termination for V_{CC} = 3.3 V

8.4.2 Input Termination

The CDCLVP1208 inputs can be interfaced with LVPECL, LVDS, or LVCMOS drivers. Figure 14 illustrates how to dc couple an LVCMOS input to the CDCLVP1208. The series resistance (R_S) should be placed close to the LVCMOS driver; its value is calculated as the difference between the transmission line impedance and the driver output impedance.

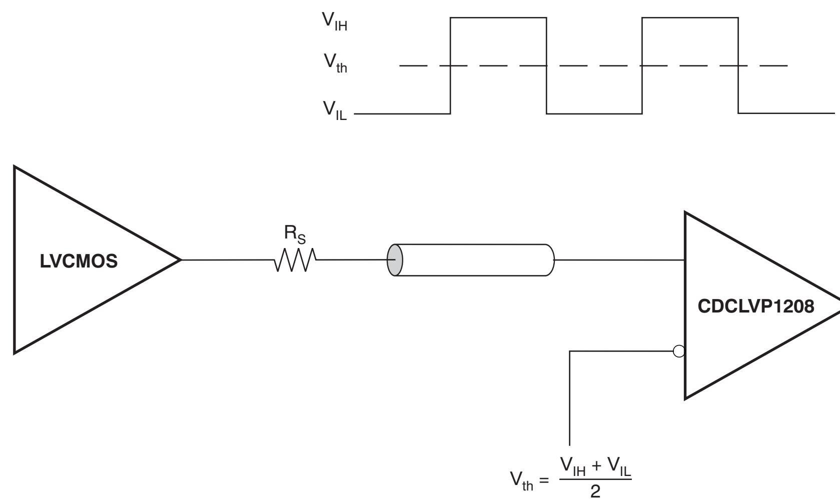


Figure 14. DC-Coupled LVCMOS Input to CDCLVP1208

Device Functional Modes (continued)

Figure 15 shows how to DC couple LVDS inputs to the CDCLVP1208. Figure 16 and Figure 17 describe the method of DC coupling LVPECL inputs to the CDCLVP1208 for V_{CC} = 2.5 V and V_{CC} = 3.3 V, respectively.

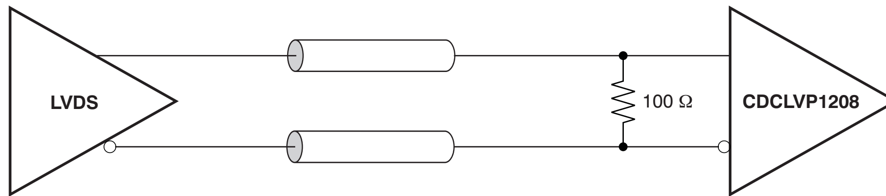


Figure 15. DC-Coupled LVDS Inputs to CDCLVP1208

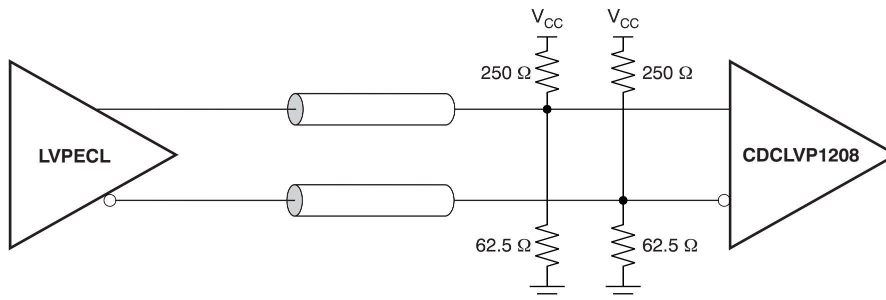


Figure 16. DC-Coupled LVPECL Inputs to CDCLVP1208 (V_{CC} = 2.5 V)

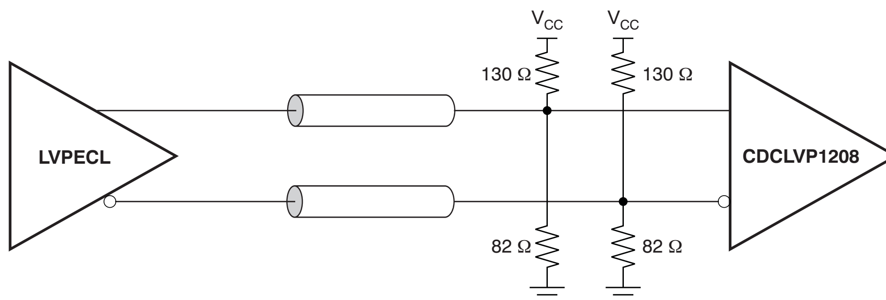


Figure 17. DC-Coupled LVPECL Inputs to CDCLVP1208 (V_{CC} = 3.3 V)

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Device Functional Modes (continued)

Figure 18 and Figure 19 show the technique of AC coupling differential inputs to the CDCLVP1208 for V_{CC} = 2.5 V and V_{CC} = 3.3 V, respectively. It is recommended to place all resistive components close to either the driver end or the receiver end. If the supply voltages of the driver and receiver are different, AC coupling is required.

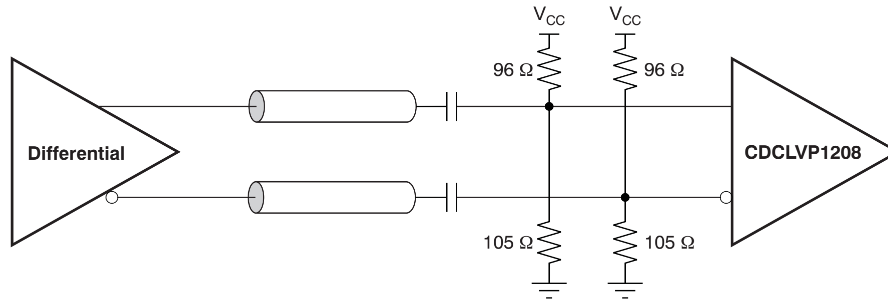

Figure 18. AC-Coupled Differential Inputs to CDCLVP1208 (V_{CC} = 2.5 V)

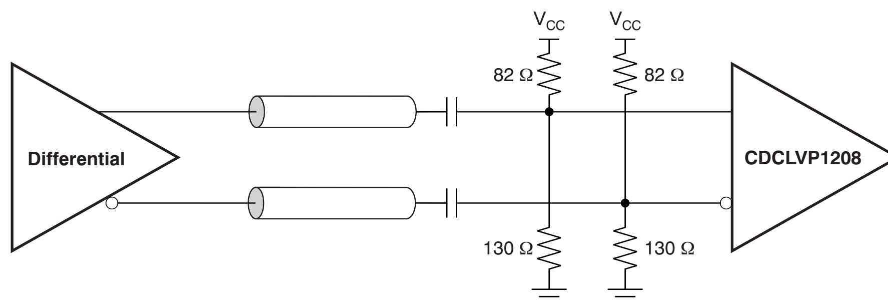

Figure 19. AC-Coupled Differential Inputs to CDCLVP1208 (V_{CC} = 3.3 V)

9 Applications and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The CDCLVP1208 is a low additive jitter LVPECL fanout buffer that can generate four copies of two selectable LVPECL, LVDS, or LVCMOS inputs. The CDCLVP1208 can accept reference clock frequencies up to 2 GHz while providing low output skew.

9.2 Typical Application

9.2.1 Fanout Buffer for Line Card Application

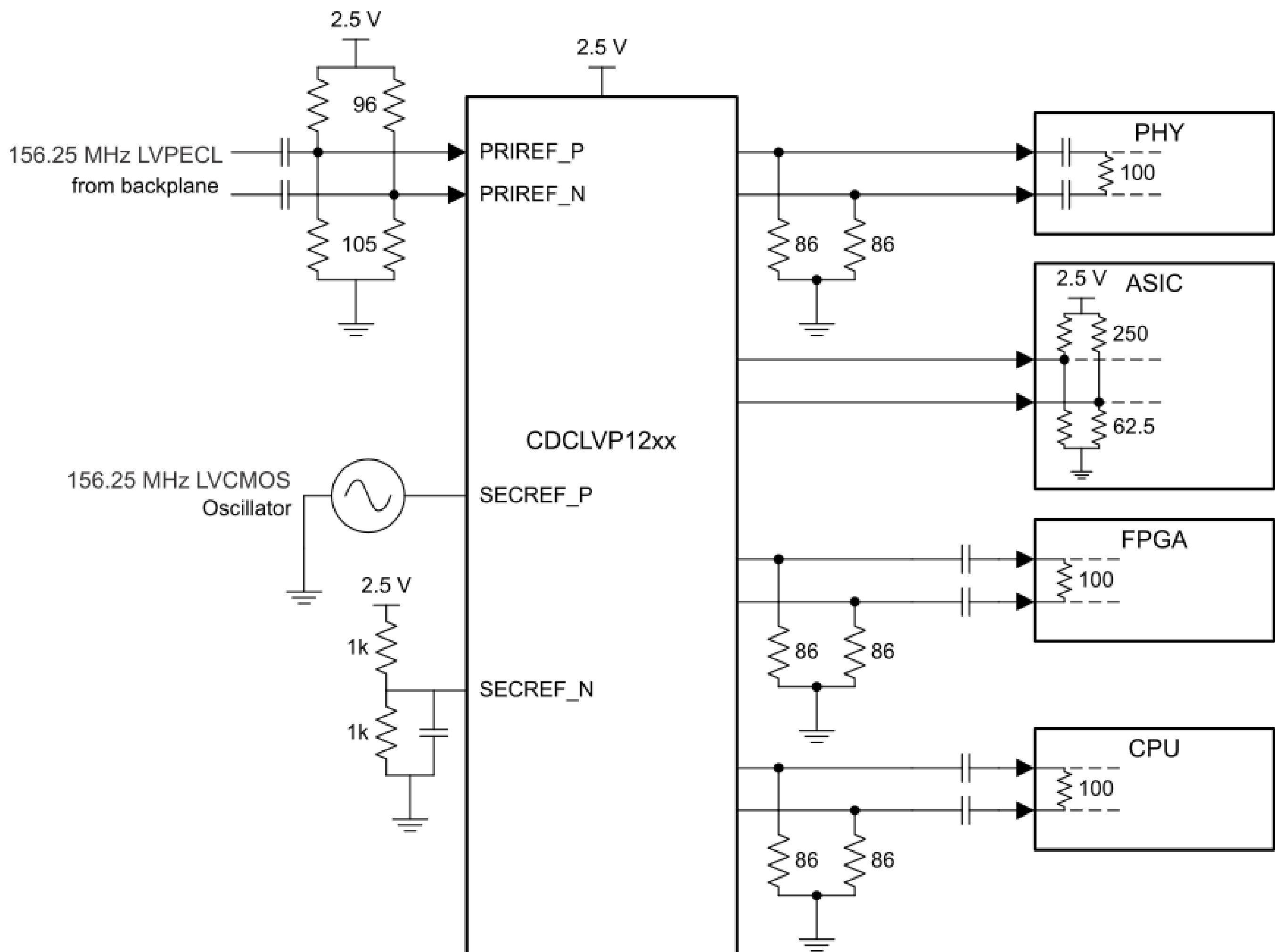

Figure 20. CDCLVP1208 Block Diagram

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Typical Application (continued)

9.2.2 Design Requirements

The CDCLVP1208 shown in Figure 20 is configured to be able to select two inputs, a 156.25-MHz LVPECL clock from the backplane, or a secondary 156.25 MHz LVCMOS 2.5V oscillator. Either signal can be then fanned out to desired devices, as shown.

The configuration example is driving 4 LVPECL receivers in a line-card application with the following properties:

- The PHY device has internal AC coupling and appropriate termination and biasing. The CDCLVP1208 will need to be provided with 86-Ω emitter resistors near the driver for proper operation.
- The ASIC is capable of DC coupling with a 2.5-V LVPECL driver such as the CDCLVP1208. This ASIC features internal termination so no additional components are needed.
- The FPGA requires external AC coupling but has internal termination. Again, 86-Ω emitter resistors are placed near the CDCLVP1208, and 0.1-µF capacitors are placed to provide AC coupling. Similarly, the CPU is internally terminated and requires external AC-coupling capacitors.

9.2.3 Detailed Design Procedure

Refer to *Input Termination* for proper input terminations, dependent on single ended or differential inputs.

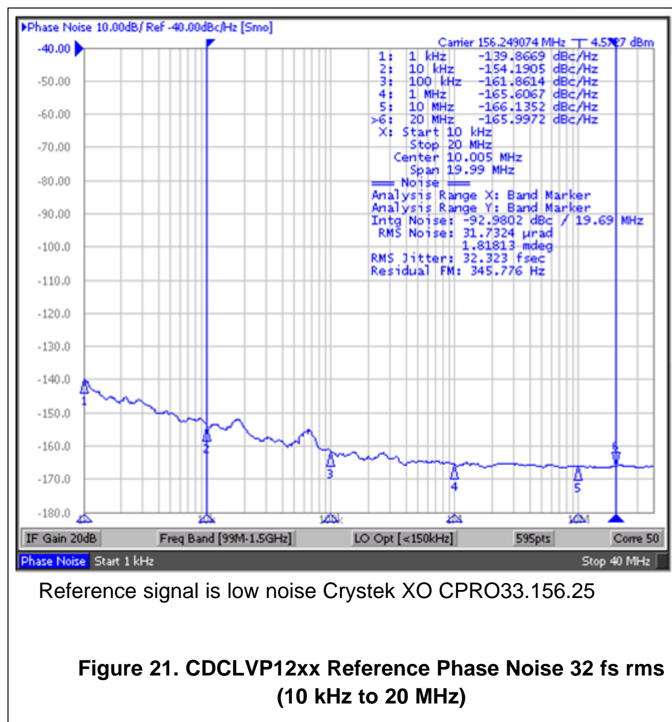
Refer to *LVPECL Output Termination* for output termination schemes depending on the receiver application.

Unused outputs can be left floating.

In this example, the PHY, ASIC, and FPGA/CPU require different schemes. Power supply filtering and bypassing is critical for low noise applications.

See *Power Supply Recommendations* for recommended filtering techniques. A reference layout is provided on the CDCLVP1208 Evaluation Module at SCAU038.

9.2.3.1 Application Curves



Reference signal is low noise Crystek XO CPRO33.156.25

Figure 21. CDCLVP12xx Reference Phase Noise 32 fs rms (10 kHz to 20 MHz)

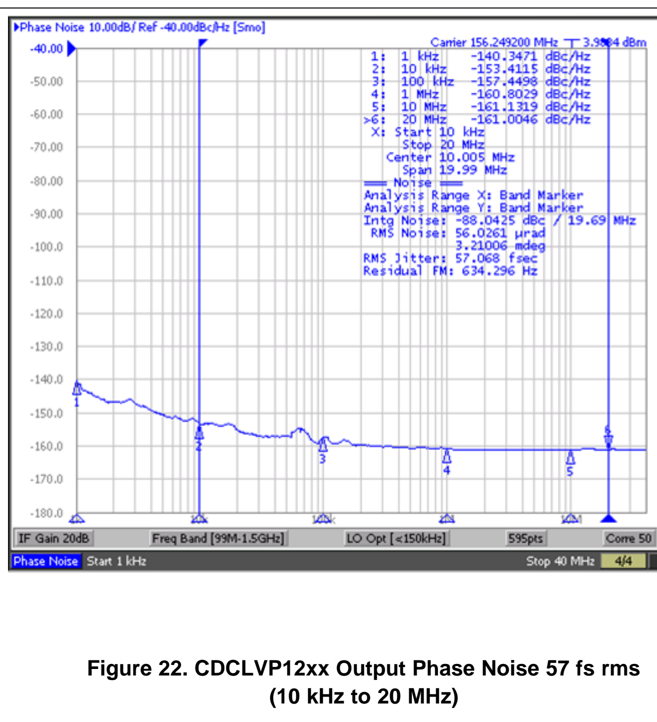


Figure 22. CDCLVP12xx Output Phase Noise 57 fs rms (10 kHz to 20 MHz)

The low additive noise of the CDCLVP12xx can be shown in this line-card application. The low noise 156.25-MHz XO with 32-fs RMS jitter drives the CDCLVP12xx, resulting in 57-fs RMS when integrated from 10 kHz to 20 MHz. The resultant additive jitter is a low 47-fs RMS for this configuration.

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10 Power Supply Recommendations

10.1 Thermal Management

Power consumption of the CDCLVP1208 can be high enough to require attention to thermal management. For reliability and performance reasons, the die temperature should be limited to a maximum of 125°C. That is, as an estimate, ambient temperature (T_A) plus device power consumption times $R_{θJA}$ should not exceed 125°C.

The device package has an exposed pad that provides the primary heat removal path to the printed circuit board (PCB). To maximize the heat dissipation from the package, a thermal landing pattern including multiple vias to a ground plane must be incorporated into the PCB within the footprint of the package. The exposed pad must be soldered down to ensure adequate heat conduction out of the package. Figure 24 shows a recommended land and via pattern.

10.2 Power-Supply Filtering

High-performance clock buffers are sensitive to noise on the power supply, which can dramatically increase the additive jitter of the buffer. Thus, it is essential to reduce noise from the system power supply, especially when jitter/phase noise is very critical to applications.

Filter capacitors are used to eliminate the low-frequency noise from the power supply, where the bypass capacitors provide the very low impedance path for high-frequency noise and guard the power-supply system against the induced fluctuations. These bypass capacitors also provide instantaneous current surges as required by the device and should have low equivalent series resistance (ESR). To properly use the bypass capacitors, they must be placed very close to the power-supply terminals and laid out with short loops to minimize inductance. It is recommended to add as many high-frequency (for example, 0.1-µF) bypass capacitors as there are supply terminals in the package. It is recommended, but not required, to insert a ferrite bead between the board power supply and the chip power supply that isolates the high-frequency switching noises generated by the clock driver; these beads prevent the switching noise from leaking into the board supply. It is imperative to choose an appropriate ferrite bead with very low DC resistance in order to provide adequate isolation between the board supply and the chip supply, as well as to maintain a voltage at the supply terminals that is greater than the minimum voltage required for proper operation.

Figure 23 illustrates this recommended power-supply decoupling method.

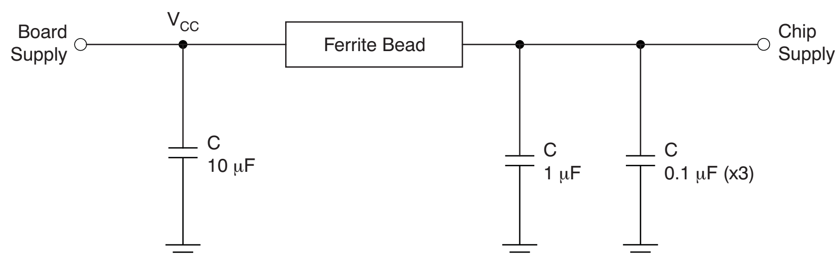

Figure 23. Power-Supply Decoupling

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11 Layout

11.1 Layout Guidelines

Power consumption of the CDCLVP1208 can be high enough to require attention to thermal management. For reliability and performance reasons, the die temperature should be limited to a maximum of 125°C. That is, as an estimate, ambient temperature (TA) plus device power consumption times $R_{\theta JA}$ should not exceed 125°C.

The device package has an exposed pad that provides the primary heat removal path to the printed circuit board (PCB). To maximize the heat dissipation from the package, a thermal landing pattern including multiple vias to a ground plane must be incorporated into the PCB within the footprint of the package. The exposed pad must be soldered down to ensure adequate heat conduction out of the package. Figure 24 shows a recommended land and via pattern.

11.2 Layout Example

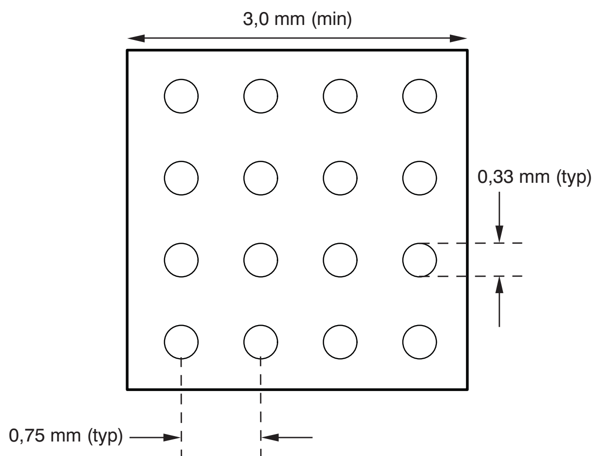

Figure 24. Recommended PCB Layout

11.3 Thermal Considerations

The CDCLVP1208 supports high temperatures on the printed circuit board (PCB) measured at the thermal pad. The system designer needs to ensure that the maximum junction temperature is not exceeded. Ψ_{jb} can allow the system designer to measure the board temperature with a fine gauge thermocouple and back calculate the junction temperature using Equation 1. Note that Ψ_{jb} is close to $R_{\theta JB}$ as 75% to 95% of the heat of a device is dissipated by the PCB. For further information, refer to SPRA953 and SLUA566.

$$T_{junction} = T_{PCB} + (\Psi_{jb} \times Power) \quad (1)$$

Example:

Calculation of the junction-lead temperature with a 4-layer JEDEC test board using four thermal vias:

T_{PCB} = 105°C

Ψ_{jb} = 11.4°C/W

$Power_{inclTerm} = I_{max} \times V_{max}$ = 355 mA × 3.6 V = 1278 mW (max power consumption including termination resistors)

$Power_{exclTerm}$ = 976 mW (max power consumption excluding termination resistors, see SLYT127 for further details)

$\Delta T_{Junction} = \Psi_{jb} \times Power_{exclTerm}$ = 11.4°C/W × 976 mW = 11.13°C

$T_{Junction} = \Delta T_{Junction} + T_{Chassis}$ = 11.13°C + 105 °C = 116.13°C (the maximum junction temperature of 125°C is not violated)

12 Device and Documentation Support

12.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community ***TI's Engineer-to-Engineer (E2E) Community.*** Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support ***TI's Design Support*** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.2 Trademarks

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.4 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CDCLVP1208RHDR	ACTIVE	VQFN	RHD	28	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR		CDCLVP 1208	Samples
CDCLVP1208RHDT	ACTIVE	VQFN	RHD	28	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR		CDCLVP 1208	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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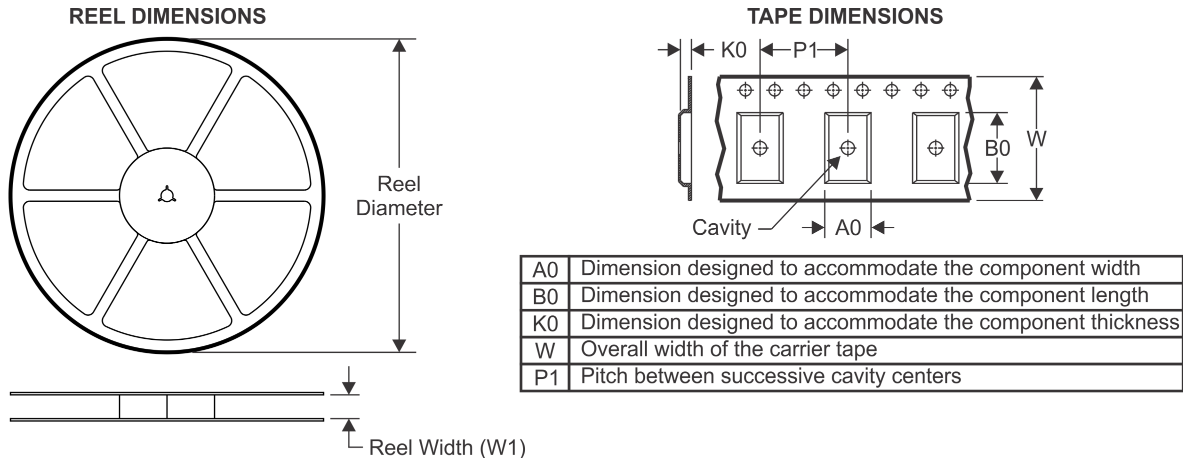
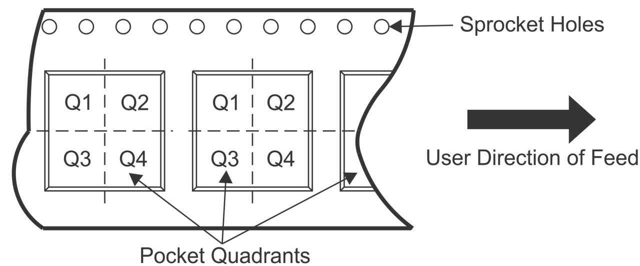
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



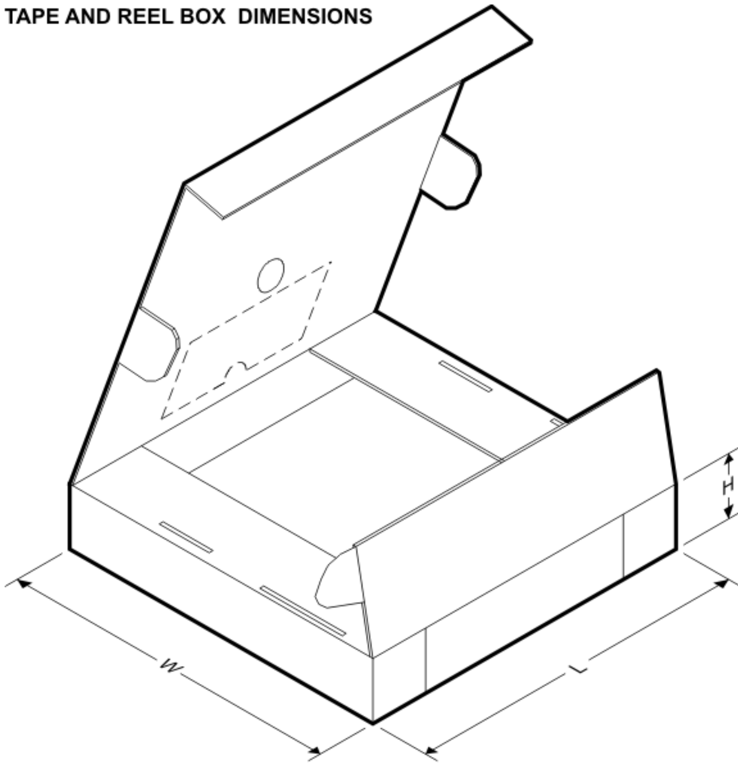
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCLVP1208RHDR	VQFN	RHD	28	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2
CDCLVP1208RHDT	VQFN	RHD	28	250	180.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2

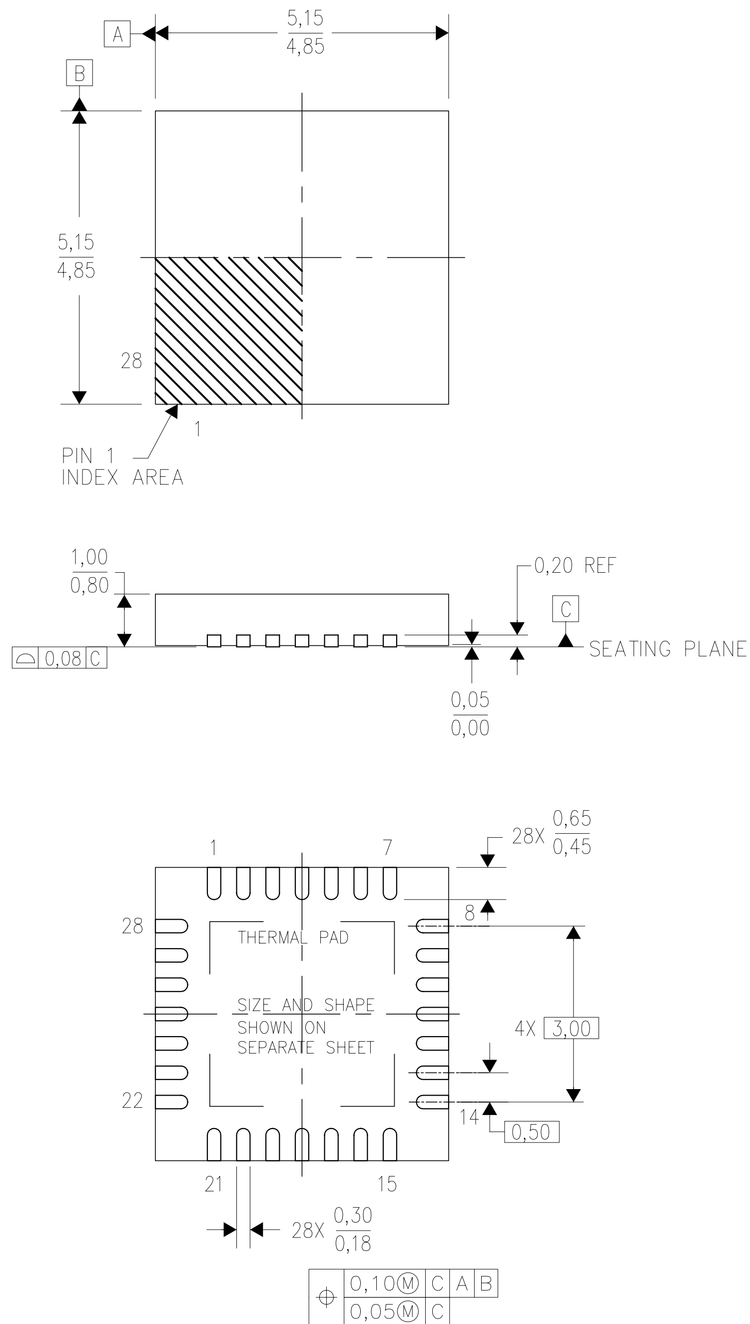
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCLVP1208RHDR	VQFN	RHD	28	3000	336.6	336.6	28.6
CDCLVP1208RHDT	VQFN	RHD	28	250	210.0	185.0	35.0

RHD (S-PVQFN-N28) PLASTIC QUAD FLATPACK NO-LEAD



4204400/F 09/11

NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M–1994.
- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No–Lead) Package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- F. Falls within JEDEC MO–220.

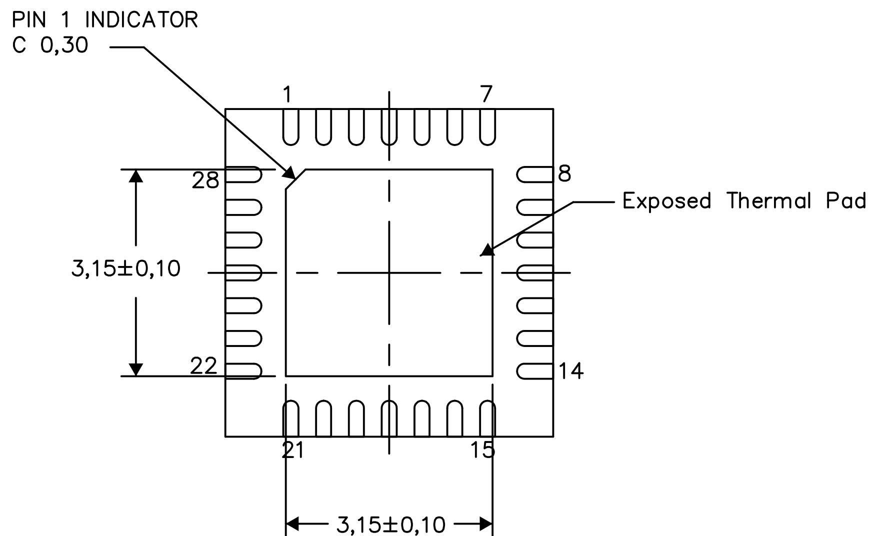
RHD (S-PVQFN-N28) PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



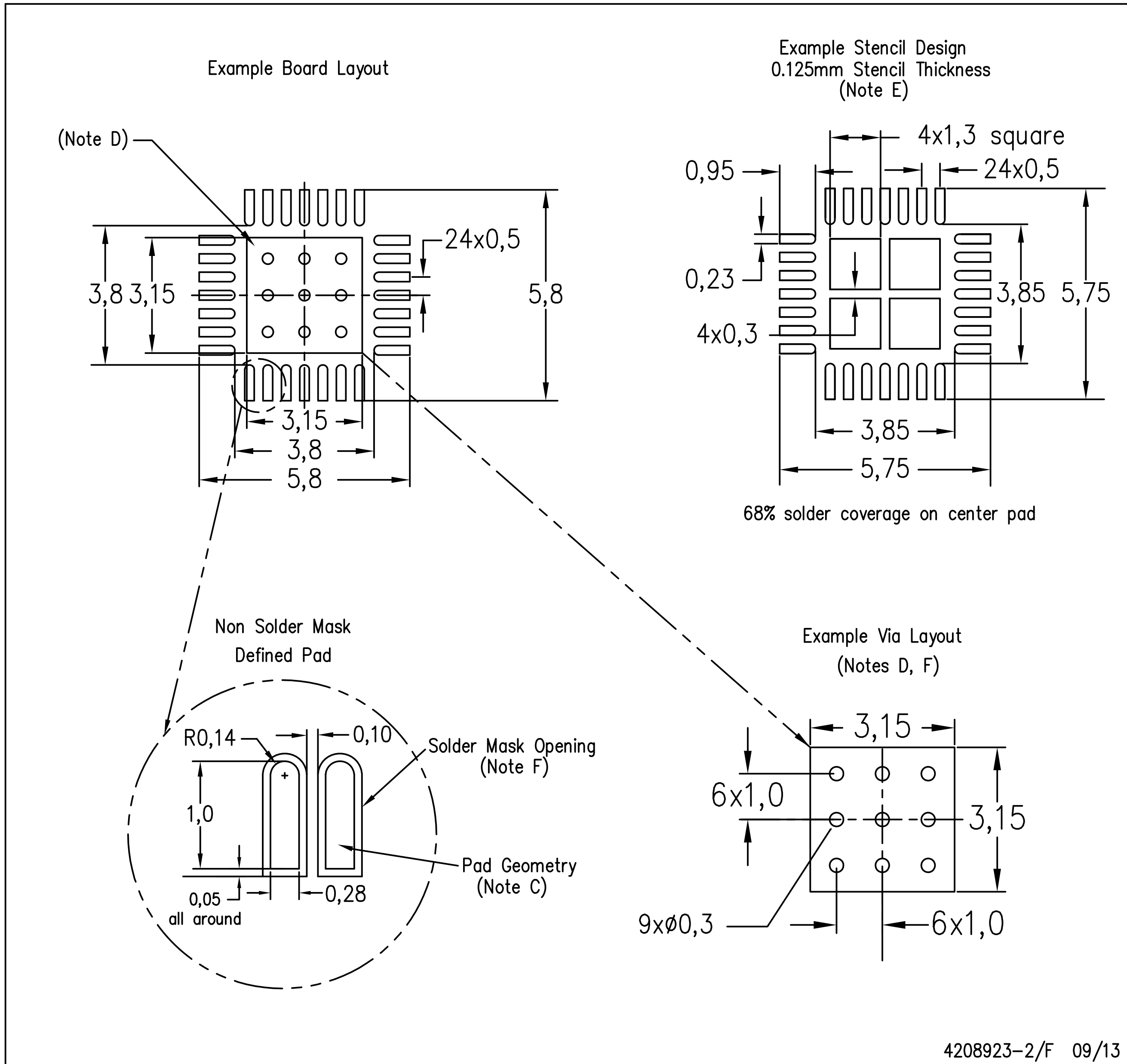
Bottom View

Exposed Thermal Pad Dimensions

4206358-2/L 05/15

NOTE: All linear dimensions are in millimeters

RHD (S-PVQFN-N28) PLASTIC QUAD FLATPACK NO-LEAD



NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC-7351 is recommended for alternate designs.
D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http: //www.ti.com>.
E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in thermal pad.

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